



#### COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

#### **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	<b>I</b> <sub>D</sub> T <sub>A</sub> = 25°C
Q1	30V	60mΩ @ V <sub>GS</sub> = 10V	3.4A
Q1 30V	30 V	100mΩ @ $V_{GS} = 4.5V$	2.7A
02	201/	95m $\Omega$ @ V <sub>GS</sub> = -10V	-2.8A
Q2	-30V	140mΩ @ V <sub>GS</sub> = -4.5V	-2.3A

### **Description and Applications**

This new generation MOSFET has been designed to minimize the onstate resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

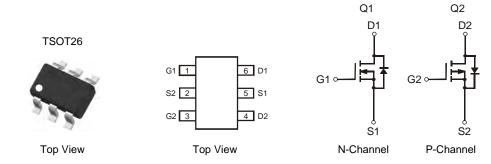
- Backlighting
- DC-DC Converters
- Power management functions

#### **Features and Benefits**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free Finish; RoHS compliant (Note 1)
- Halogen and Antimony Free. "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

#### **Mechanical Data**

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe.
   Solderable per MIL-STD-202, Method 208
- Weight: 0.013 grams (approximate)



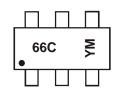
#### Ordering Information (Note 3)

-			
	Part Number	Case	Packaging
	DMG6602SVT-7	TSOT26	3000 / Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.
- 2. Halogen and Antimony free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 3. For packaging details, go to our website at http://www.diodes.com.

### **Marking Information**



66C = Product Type Marking Code YM = Date Code Marking Y = Year (ex: X = 2010) M = Month (ex: 9 = September)

Date Code Key

Year	2010		2011	2012		2013	2014		2015	2016		2017
Code	X		Υ	Z		Α	В		С	D		E
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# Maximum Ratings − Q1 @TA = 25°C unless otherwise specified

Characteristi	Symbol	Value	Unit		
Drain-Source Voltage			V <sub>DSS</sub>	30	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	V		
Continuous Drain Current (Note 5) V <sub>GS</sub> = 10V	Steady State	T <sub>A</sub> = 25°C T <sub>A</sub> = 70°C	I <sub>D</sub>	3.4 2.7	А
Continuous Drain Current (Note 5) V <sub>GS</sub> = 4.5V	I <sub>D</sub>	2.7 2.2	А		
Maximum Continuous Body Diode Forward Current (	Is	1.5	Α		
Pulsed Drain Current (Note 5)	•		I <sub>DM</sub>	25	A

# Maximum Ratings - Q2 @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage	V <sub>DSS</sub>	-30	V		
Gate-Source Voltage	V <sub>GSS</sub>	±20	V		
Continuous Drain Current (Note 5) V <sub>GS</sub> = -10V	Steady State	T <sub>A</sub> = 25°C T <sub>A</sub> = 70°C	I <sub>D</sub>	-2.8 -2.4	А
Continuous Drain Current (Note 5) V <sub>GS</sub> = -4.5V	I <sub>D</sub>	-2.3 -2.1	А		
Maximum Continuous Body Diode Forward Current (	Is	-1.5	А		
Pulsed Drain Current (Note 5)	I <sub>D</sub>	-20	Α		

## **Thermal Characteristics**

Characteristic	Symbol	Value	Units		
Total Power Dissipation (Note 4)	T <sub>A</sub> = 25°C	Б	0.84	W	
Total Power Dissipation (Note 4)	T <sub>A</sub> = 70°C	P <sub>D</sub>	0.52		
Thermal Resistance, Junction to Ambient (Note 4)	Steady state	В	155	°C/W	
Thermal Resistance, Junction to Ambient (Note 4)	t<10s	$R_{ hetaJA}$	109	C/VV	
Total Power Dissipation (Note 5)	$T_A = 25^{\circ}C$	PD	1.27	w	
Total Fower Dissipation (Note 3)	$T_A = 70^{\circ}C$	FD	0.8	VV	
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	В	102		
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	71	°C/W	
Thermal Resistance, Junction to Case (Note 5)		$R_{ heta JC}$	34		
Operating and Storage Temperature Range		$T_{J_1}T_{STG}$	-55 to +150	ů	

4. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout. 5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

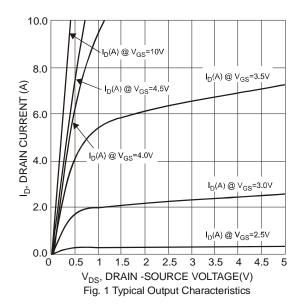


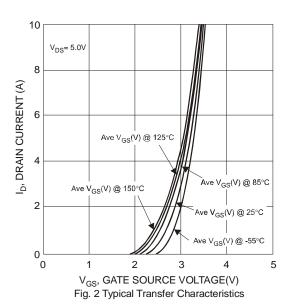
## Electrical Characteristics - Q1 NMOS@ TA = 25°C unless otherwise stated

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)		-	ā.		a.	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	-	-	1.0	μΑ	$V_{DS} = 24V$ , $V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.0	-	2.3	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Static Drain-Source On-Resistance	R <sub>DS (ON)</sub>	-	38 55	60 100	mΩ	$V_{GS} = 10V, I_D = 3.1A$
Forward Transfer Admittance	Y <sub>fs</sub>	-	4	-	S	$V_{GS} = 4.5V, I_D = 2A$ $V_{DS} = 5V, I_D = 3.1A$
Diode Forward Voltage	V <sub>SD</sub>	-	0.8	1	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 7)	•				•	
Input Capacitance	C <sub>iss</sub>	-	290	400		V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V, f = 1.2MHz
Output Capacitance	Coss	-	40	80	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	-	40	80		
Gate Resistance	Rg	-	1.4	-	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	-	4	6		$V_{DS} = 15V$ , $V_{GS} = 4.5V$ , $I_{D} = 3.1A$
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	-	9	13		
Gate-Source Charge	Qgs	-	1.2	-	nC	$V_{DS} = 15V, V_{GS} = 10V, I_D = 3A$
Gate-Drain Charge	$Q_{gd}$	-	1.5	-		
Turn-On Delay Time	t <sub>D(on)</sub>	-	3	-		
Turn-On Rise Time	t <sub>r</sub>	-	5	-		$V_{GS} = 10V, V_{DS} = 15V,$
Turn-Off Delay Time	t <sub>D(off)</sub>	-	13	-	ns	$R_G = 3\Omega$ , $R_L = 4.7\Omega$
Turn-Off Fall Time	t <sub>f</sub>	-	3	-		

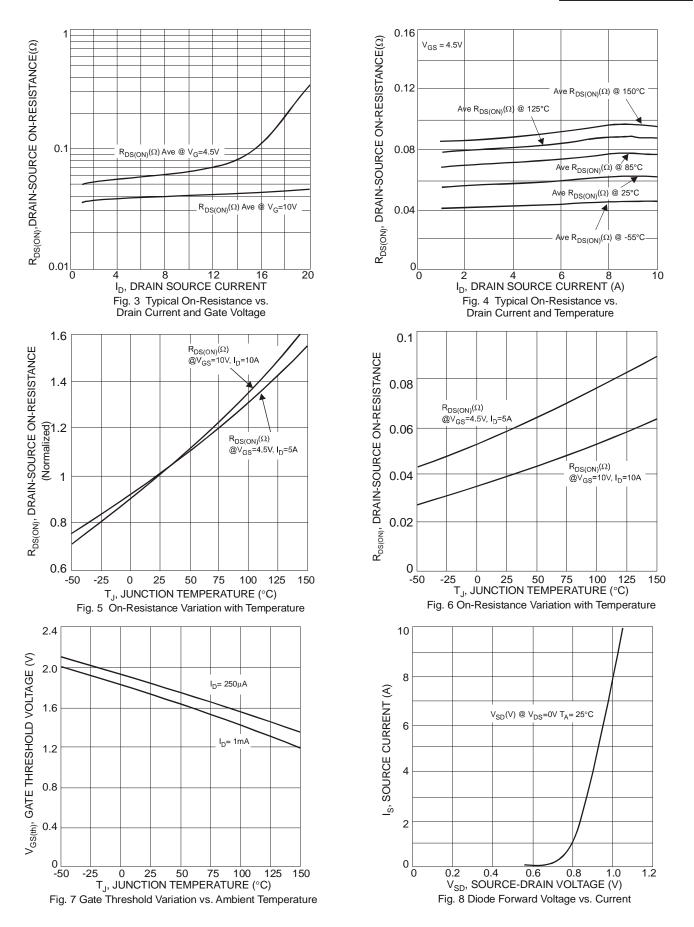
Notes:

- 6. Short duration pulse test used to minimize self-heating effect. 7. Guaranteed by design. Not subject to product testing.

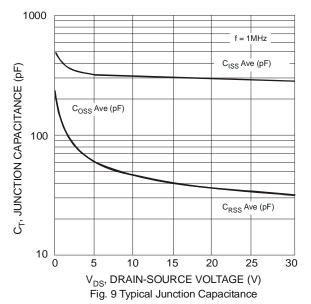


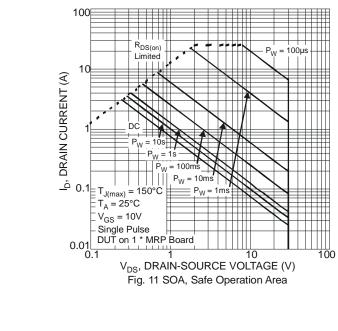


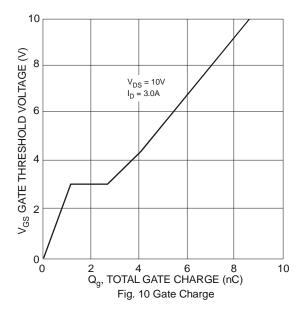












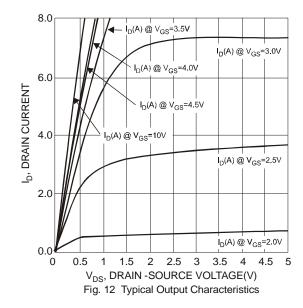


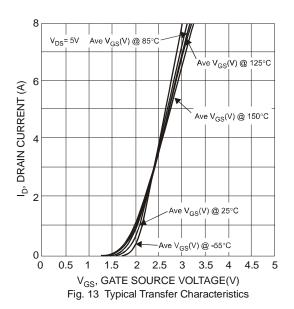
## Electrical Characteristics – Q2 PMOS@ TA = 25°C unless otherwise stated

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)				-		
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	-	-	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	-	-	-1.0	μΑ	$V_{DS} = -24V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	$V_{GS(th)}$	-1.0	-	-2.3	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance			73	95	mΩ	$V_{GS} = -10V, I_D = -2.7A$
Static Drain-Source On-Resistance	R <sub>DS</sub> (ON)	-	99	140	11177	$V_{GS} = -4.5V, I_D = -2A$
Forward Transfer Admittance	Y <sub>fs</sub>	-	6	-	S	$V_{DS} = -5V, I_{D} = -2.7A$
Diode Forward Voltage	V <sub>SD</sub>	-	-0.8	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	C <sub>iss</sub>	-	350	420		$V_{DS} = -15V, V_{GS} = 0V,$ f = 1.2MHz
Output Capacitance	Coss	-	50	100	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	-	45	80		
Gate Resistance	$R_g$	-	17.1	-	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$
Total Gate Charge (V <sub>GS</sub> = -4.5V)	Qg	-	4	6		$V_{DS} = -15V$ , $V_{GS} = -4.5V$ , $I_{D} = -3A$
Total Gate Charge (V <sub>GS</sub> = -10V)	Qq	-	7	9		
Gate-Source Charge	Q <sub>gs</sub>	-	0.9	-	nC	$V_{DS} = -15V, V_{GS} = -10V, I_{D} = -3A$
Gate-Drain Charge	Q <sub>gd</sub>	-	1.2	-		
Turn-On Delay Time	t <sub>D(on)</sub>	-	4.8	-		
Turn-On Rise Time	t <sub>r</sub>	-	7.3	-		$V_{GS} = -10V, V_{DS} = -15V,$
Turn-Off Delay Time	t <sub>D(off)</sub>	-	20	-	ns	$R_G = 6\Omega$ , $R_L = 15\Omega$
Turn-Off Fall Time	t <sub>f</sub>	-	13	-		

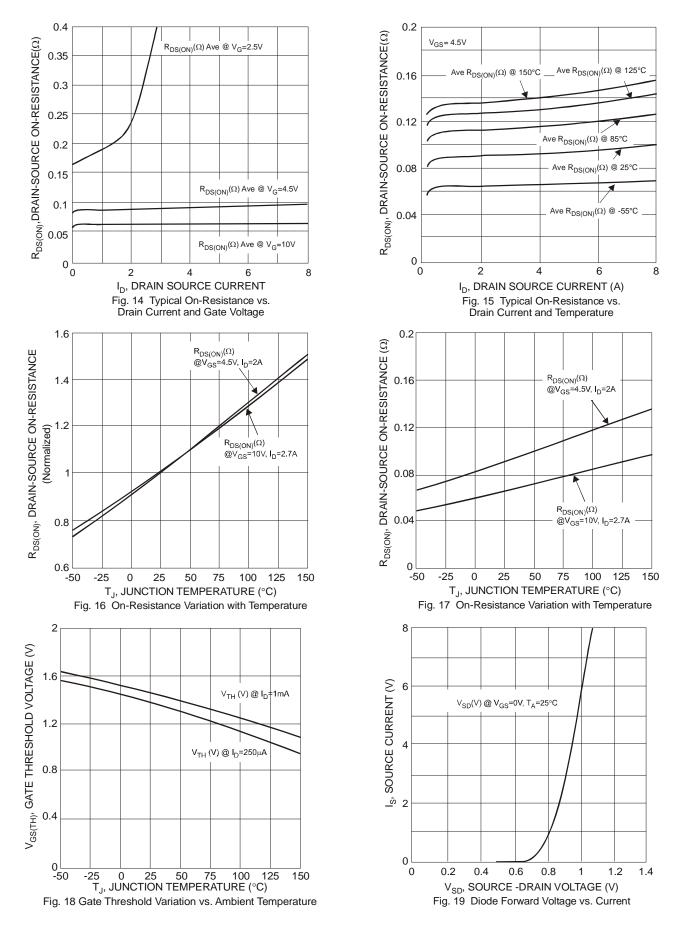
Notes:

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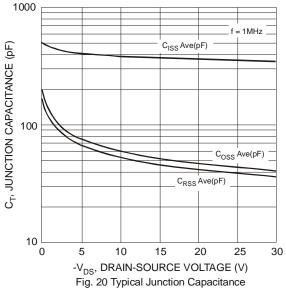


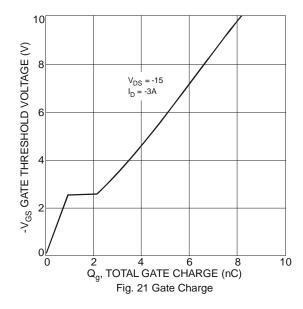


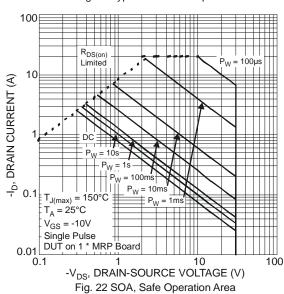


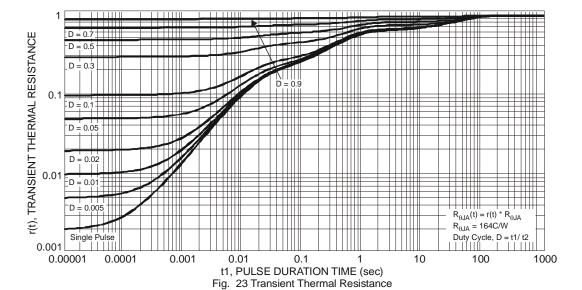






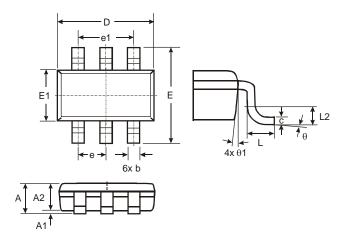






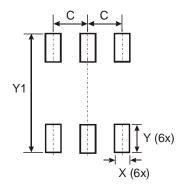


# **Package Outline Dimensions**



	TSOT26							
Dim	Min	Max	Тур					
Α	-	1.00	_					
<b>A</b> 1	0.01	0.10	_					
A2	0.84	0.90	_					
D	-	_	2.90					
Е	_	_	2.80					
E1	E1 –		1.60					
b	<b>b</b> 0.30		_					
U	0.12	0.20	_					
е	-	_	0.95					
e1	-	_	1.90					
L	0.30	0.50						
L2	-	_	0.25					
θ	0°	8°	4°					
θ1	4°	12°	_					
All D	imensi	ons in	mm					

# Suggested Pad Layout



Dimensions	Value (in mm)
С	0.950
Х	0.700
Υ	1.000
Y1	3.199



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